## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under | Reexamination | CHOWN, DAVID | Examiner | LI LIU | 2613 | Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,432,874	07-1995	Muraguchi, Takahiro	385/24
*	В	US-6,374,021	04-2002	Nakanishi et al.	385/49
*	C	US-5,661,835	08-1997	Kato et al.	385/92
*	D	US-2002/0064333	05-2002	Shigeta et al.	385/14
*	Е	US-5,329,394	07-1994	Calvani et al.	398/152
*	F	US-5,710,652	01-1998	Bloom et al.	398/129
*	G	US-2002/0171890	11-2002	Lin et al.	359/124
	Η	US-			
	I	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Ø					
	R					
	Ø					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.